

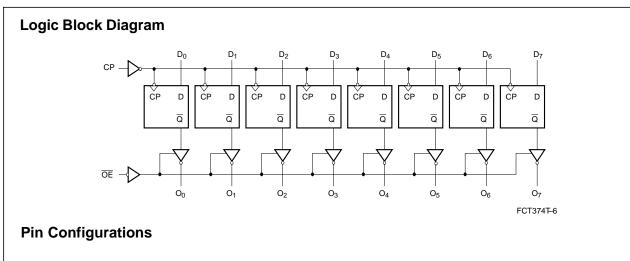
SCCS022 - May 1994 - Revised February 2000

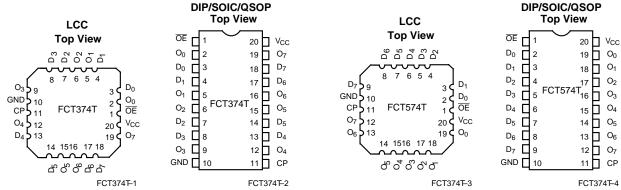
# 8-Bit Registers

#### **Features**

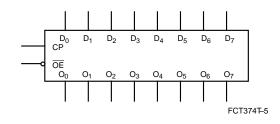
- Function, pinout, and drive compatible with FCT and F logic
- FCT-C speed at 5.2 ns max. (Com'l) FCT-A speed at 6.5 ns max. (Com'l)
- Reduced V<sub>OH</sub> (typically = 3.3V) versions of equivalent FCT functions
- Edge-rate control circuitry for significantly improved noise characteristics
- Power-off disable feature

- · Matched rise and fall times
- Fully compatible with TTL input and output logic levels
- ESD > 2000V
- Extended commercial range of -40°C to +85°C
- Sink Current 64 mA (Com'l), 32 mA (Mil) Source Current 32 mA (Com'l), 12 mA (Mil)
- Edge-triggered D-type inputs
- · 250 MHz typical toggle rate





## **Logic Symbol**





### **Functional Description**

The FCT374T and FCT574T are high-speed low-power octal D-type flip-flops featuring separate D-type inputs for each flip-flop. Both devices have three-state outputs for bus oriented applications. A buffered clock (CP) and output enable (OE) are common to all flip-flops. The FCT574T is identical to FCT374T except for flow-through pinout to simplify board design. The eight flip-flops contained in the FCT374T and FCT574T will store the state of their individual D inputs that meet the set-up and hold time requirements on the LOW-to-HIGH clock (CP) transition. When OE is LOW, the contents of the eight flip-flops are available at the outputs. When  $\overline{\text{OE}}$  is HIGH, the outputs will be in the high-impedance state. The state of output enable does not affect the state of the flip-flops.

The outputs are designed with a power-off disable feature to allow for live insertion of boards.

#### Function Table<sup>[1]</sup>

	Inputs	Outputs	
D	СР	0	
Н		L	Н
L	I	L	L
Х	Х	Н	Z

## Maximum Ratings<sup>[2, 3]</sup>

(Above which the useful life may be impallines, not tested.)	ired. For user guide
Storage Temperature	65°C to +150°C
Ambient Temperature with Power Applied	–65°C to +135°C
Supply Voltage to Ground Potential	0.5V to +7.0V
DC Input Voltage	0.5V to +7.0V
DC Output Voltage	0.5V to +7.0V
DC Output Current (Maximum Sink Curre	ent/Pin) 120 mA
Power Dissipation	0.5W
Static Discharge Voltage(per MIL-STD-883, Method 3015)	

## **Operating Range**

Range	Range	Ambient Temperature	v <sub>cc</sub>
Commercial	T, AT, CT	–40°C to +85°C	5V ± 5%
Military <sup>[4]</sup>	All	–55°C to +125°C	5V ± 10%

#### **Electrical Characteristics** Over the Operating Range

Parameter	Description	Test Condition	ıs	Min.	<b>Typ</b> . <sup>[5]</sup>	Max.	Unit
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> =Min., I <sub>OH</sub> =–32 mA	Com'l	2.0			V
		V <sub>CC</sub> =Min., I <sub>OH</sub> =–15 mA	Com'l	2.4	3.3		V
		V <sub>CC</sub> =Min., I <sub>OH</sub> =–12 mA	Mil	2.4	3.3		V
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> =Min., I <sub>OL</sub> =64 mA	Com'l		0.3	0.55	V
		V <sub>CC</sub> =Min., I <sub>OL</sub> =32 mA	Mil		0.3	0.55	V
V <sub>IH</sub>	Input HIGH Voltage			2.0			V
V <sub>IL</sub>	Input LOW Voltage					0.8	V
$V_{H}$	Hysteresis <sup>[6]</sup>	All inputs			0.2		V
V <sub>IK</sub>	Input Clamp Diode Voltage	V <sub>CC</sub> =Min., I <sub>IN</sub> =–18 mA			-0.7	-1.2	V
I <sub>I</sub>	Input HIGH Current	V <sub>CC</sub> =Max., V <sub>IN</sub> =V <sub>CC</sub>				5	μΑ
I <sub>IH</sub>	Input HIGH Current	V <sub>CC</sub> =Max., V <sub>IN</sub> =2.7V				±1	μΑ
I <sub>IL</sub>	Input LOW Current	V <sub>CC</sub> =Max., V <sub>IN</sub> =0.5V				±1	μΑ
I <sub>OZH</sub>	Off State HIGH-Level Output Current	$V_{CC} = Max., V_{OUT} = 2.7V$				10	μА
I <sub>OZL</sub>	Off State LOW-Level Output Current	$V_{CC} = Max., V_{OUT} = 0.5V$				-10	μА
Ios	Output Short Circuit Current <sup>[7]</sup>	V <sub>CC</sub> =Max., V <sub>OUT</sub> =0.0V		-60	-120	-225	mA
I <sub>OFF</sub>	Power-Off Disable	V <sub>CC</sub> =0V, V <sub>OUT</sub> =4.5V				±1	μΑ

#### Notes:

- H = HIGH Voltage Level. L = LOW Voltage Level X = Don't Care Z = HIGH Impedance = LOW-to-HIGH clock transition
- Unless otherwise noted, these limits are over the operating free-air temperature range. Unused inputs must always be connected to an appropriate logic voltage level, preferably either  $V_{CC}$  or ground.
- T<sub>A</sub> is the "instant on" case temperature.
- Typical values are at  $V_{CC}$ =5.0 $\dot{V}$ ,  $T_A$ =+25 $^{\circ}$ C ambient.
- This parameter is specified but not tested.

  Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample and hold techniques are preferable in order to minimize internal chip heating and more accurately reflect operational values. Otherwise prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parameters tests. In any sequence of parameter tests, I<sub>OS</sub> tests should be performed last.



## Capacitance<sup>[2]</sup>

Parameter	Description	Typ. <sup>[5]</sup>	Max.	Unit
C <sub>IN</sub>	Input Capacitance	5	10	pF
C <sub>OUT</sub>	Output Capacitance	9	12	pF

## **Power Supply Characteristics**

Parameter	Description	Test Conditions	Typ. <sup>[5]</sup>	Max.	Unit
Icc	Quiescent Power Supply Current	V <sub>CC</sub> =Max., V <sub>IN</sub> ≤0.2V, V <sub>IN</sub> ≥V <sub>CC</sub> -0.2V	0.1	0.2	mA
Δl <sub>CC</sub>	Quiescent Power Supply Current (TTL inputs HIGH)	V <sub>CC</sub> =Max., V <sub>IN</sub> =3.4V, <sup>[8]</sup> f <sub>1</sub> =0, Outputs Open	0.5	2.0	mA
I <sub>CCD</sub>	Dynamic Power Supply Current <sup>[9]</sup>	V <sub>CC</sub> =Max., One Bit Toggling, 50% Duty Cycle, Outputs Open, OE=GND, V <sub>IN</sub> ≤0.2V or V <sub>IN</sub> ≥V <sub>CC</sub> −0.2V	0.06	0.12	mA/MHz
I <sub>C</sub>	Total Power Supply Current <sup>[10]</sup>	$V_{CC}=Max.$ , $f_0=10$ MHz, 50% Duty Cycle, Outputs Open, One Bit Toggling at $f_1=5$ MHz, $\overline{OE}=GND$ , $V_{IN}\leq 0.2V$ or $V_{IN}\geq V_{CC}=0.2V$	0.7	1.4	mA
		V <sub>CC</sub> =Max., f <sub>0</sub> =10 MHz, 50% Duty Cycle, Outputs Open, One Bit Toggling at f <sub>1</sub> =5 MHz, $\overline{\text{OE}}$ =GND, V <sub>IN</sub> =3.4V or V <sub>IN</sub> =GND	1.2	3.4	mA
		V <sub>CC</sub> =Max., f <sub>0</sub> =10 MHz, 50% Duty Cycle, Outputs Open, Eight Bits Toggling at f <sub>1</sub> =2.5 MHz, OE=GND, V <sub>IN</sub> ≤0.2V or V <sub>IN</sub> ≥V <sub>CC</sub> -0.2V	1.6	3.2 <sup>[11]</sup>	mA
		V <sub>CC</sub> =Max., f <sub>0</sub> =10 MHz, 50% Duty Cycle, Outputs Open, Eight Bits Toggling at f <sub>1</sub> =2.5 MHz, OE=GND, V <sub>IN</sub> =3.4V or V <sub>IN</sub> =GND	3.9	12.2 <sup>[11]</sup>	mA

#### Notes:

- 8. Per TTL driven input ( $V_{IN}$ =3.4V); all other inputs at  $V_{CC}$  or GND.
- Per TTL driven input ( $V_{IN}$ =3.4V); all other inputs at  $V_{CC}$  or GND.

  This parameter is not directly testable, but is derived for use in Total Power Supply calculations.  $\begin{vmatrix} c & l \\ C & l \\ C & l \end{vmatrix}$  QUIESCENT +  $\begin{vmatrix} l \\ INPUTS + \end{vmatrix}$   $\begin{vmatrix} l$
- f<sub>0</sub> = Clock frequency for registered devices, otherwise zero
  f<sub>1</sub> = Input signal frequency
  N<sub>1</sub> = Number of inputs changing at f<sub>1</sub>
  All currents are in milliamps and all frequencies are in megahertz.

  11. Values for these conditions are examples of the I<sub>CC</sub> formula. These limits are specified but not tested.



# **Switching Characteristics**<sup>[12]</sup> Over the Operating Range

		FCT374T/FCT574T		•	FCT374AT/FCT574AT						
		Milit	ary	Comm	ercial	Milit	ary	Comm	ercial		Fig.
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Unit	Fig. No. <sup>[13]</sup>
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay Clock to Output	2.0	11.0	2.0	10.0	2.0	7.2	2.0	6.5	ns	1, 5
t <sub>PZH</sub> t <sub>PZL</sub>	Output Enable Time	1.5	14.0	1.5	12.5	1.5	7.5	1.5	6.5	ns	1, 7, 8
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output Disable Time	1.5	8.0	1.5	8.0	1.5	6.5	1.5	5.5	ns	1, 7, 8
t <sub>S</sub>	Set-Up Time HIGH or LOW D to CP	2.0		2.0		2.0		2.0		ns	4
t <sub>H</sub>	Hold Time HIGH or LOW D to CP	1.5		1.5		1.5		1.5		ns	4
t <sub>W</sub>	Clock Pulse Width <sup>[14]</sup> HIGH or LOW	7.0		7.0		6.0		5.0		ns	5

		FCT374CT/FCT574CT			Т		
		Military Commercial			Fig.		
Parameter	Description	Min.	Max.	Min.	Max.	Unit	Fig. No. <sup>[13]</sup>
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay Clock to Output	2.0	6.2	2.0	5.2	ns	1, 5
t <sub>PZH</sub>	Output Enable Time	1.5	6.2	1.5	5.5	ns	1, 7, 8
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output Disable Time	1.5	5.7	1.5	5.0	ns	1, 7, 8
t <sub>S</sub>	Set-Up Time, HIGH or LOW D to CP	2.0		2.0		ns	4
t <sub>H</sub>	Hold Time, HIGH or LOW D to CP	1.5		1.5		ns	4
t <sub>W</sub>	Clock Pulse Width <sup>[14]</sup> HIGH or LOW	6.0		5.0		ns	5

#### Notes:

Minimum limits are specified but not tested on Propagation Delays.
 See "Parameter Measurement Information" in the General Information section.
 With one data channel toggling, t<sub>W</sub>(L)=t<sub>W</sub>(H)=4.0 ns and t<sub>r</sub>=t<sub>r</sub>=1.0 ns.



# Ordering Information—FCT374T

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
5.2	CY74FCT374CTQCT	Q5	20-Lead (150-Mil) QSOP	Commercial
	CY74FCT374CTSOC/SOCT	S5	20-Lead (300-Mil) Molded SOIC	
6.2	CY54FCT374CTDMB	D6	20-Lead (300-Mil) CerDIP	Military
	CY54FCT374CTLMB	L61	20-Pin Square Leadless Chip Carrier	
6.5	CY74FCT374ATPC	P5	20-Lead (300-Mil) Molded DIP	Commercial
	CY74FCT374ATQCT	Q5	20-Lead (150-Mil) QSOP	
	CY74FCT374ATSOC/SOCT	S5	20-Lead (300-Mil) Molded SOIC	
7.2	CY54FCT374ATLMB	L61	20-Pin Square Leadless Chip Carrier	Military
	CY54FCT374ATDMB	D6	20-Lead (300-Mil) CerDIP	
10.0	CY74FCT374TQCT	Q5	20-Lead (150-Mil) QSOP	Commercial
	CY74FCT374TSOC/SOCT	S5	20-Lead (300-Mil) Molded SOIC	
11.0	CY54FCT374TDMB	D6	20-Lead (300-Mil) CerDIP	Military
	CY54FCT374TLMB	L61	20-Pin Square Leadless Chip Carrier	

# Ordering Information—FCT574T

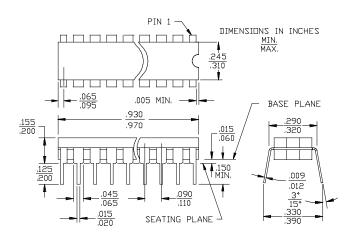
Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
5.2	CY74FCT574CTQCT	Q5	20-Lead (150-Mil) QSOP	Commercial
	CY74FCT574CTSOC/SOCT	S5	20-Lead (300-Mil) Molded SOIC	
6.2	CY54FCT574CTDMB	D6	20-Lead (300-Mil) CerDIP	Military
6.5	CY74FCT574ATQCT	Q5	20-Lead (150-Mil) QSOP	Commercial
	CY74FCT574ATSOC/SOCT	S5	20-Lead (300-Mil) Molded SOIC	
7.2	CY54FCT574ATDMB	D6	20-Lead (300-Mil) CerDIP	Military
	CY54FCT574ATLMB	L61	20-Pin Square Leadless Chip Carrier	
10.0	CY74FCT574TQCT	Q5	20-Lead (150-Mil) QSOP	Commercial
	CY74FCT574TSOC/SOCT	S5	20-Lead (300-Mil) Molded SOIC	

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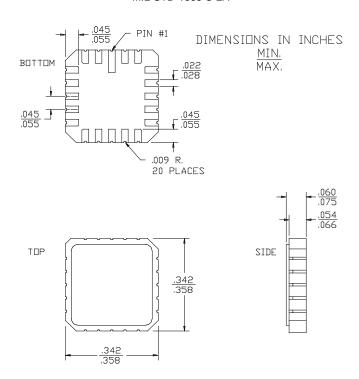


## **Package Diagrams**

## **20-Lead (300-Mil) CerDIP D6** MIL-STD-1835 D-8Config.A



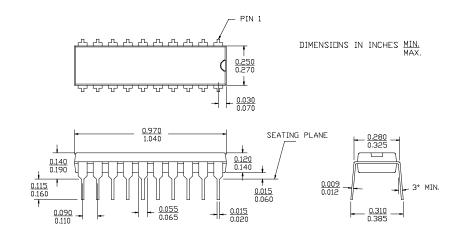
#### 20-Pin Square Leadless Chip Carrier L61 MIL-STD-1835 C-2A



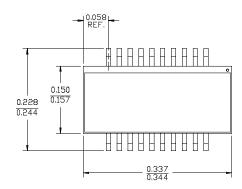


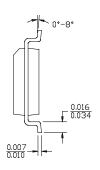
## Package Diagrams (continued)

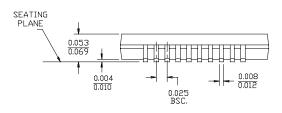
### 20-Lead (300-Mil) Molded DIP P5



### 20-Lead Quarter Size Outline Q5





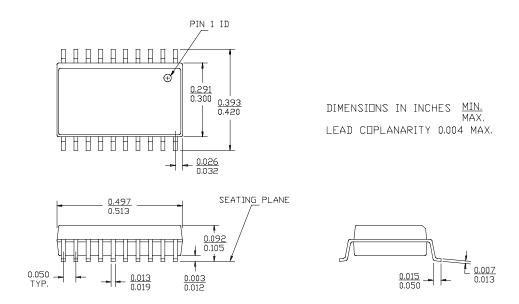


DIMENSIONS IN INCHES  $\frac{\text{MIN.}}{\text{MAX.}}$  LEAD COPLANARITY 0.004 MAX.



## Package Diagrams (continued)

### 20-Lead (300-Mil) Molded SOIC S5



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